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Inventor(s)	Cherif; Bouchaib et al.

Dynamic current-mode finite impulse response filter

Abstract

The proposed dynamic current-mode finite impulse response (FIR) filter includes a coefficient signal generator to generate a coefficient signal, an input signal generator to generate an input signal, a dynamic current multiplier configured to receive the input signal and the coefficient signal and to generate intermediate product terms that are multiplications of the coefficient values and reflected and shifted input values, and an accumulator configured to receive the intermediate product terms and to sequentially integrate the intermediate product terms over the coefficient values to produce output responses for the input values. The dynamic current multiplier includes a first dynamically configured transistor (DCT) having a first input node to receive the first input signal during a first phase of operation and a second input node to receive the second input signal during a second phase of operation, and a second DCT having an input node to receive a third input signal during a first phase of operation, and output the intermediate product terms during a second phase of operation.

Inventors:	**Cherif; Bouchaib (Yorktown Heights, NY), Doxas; Isidoros (Columbia, MD), Pouliquen; Philippe (Baltimore, MD)**
Applicant:	**NORTHROP GRUMMAN SYSTEMS CORPORATION** (Falls Church, VA)
Family ID:	**1000008767716**
Assignee:	**NORTHROP GRUMMAN SYSTEMS CORPORATION (Falls Church, VA)**
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References Cited

U.S. PATENT DOCUMENTS

Patent No.	Issued Date	Patentee Name	U.S. Cl.	CPC
5097155	12/1991	Liu	327/552	H03H 19/00
5367476	12/1993	Elliott	708/316	H03H 17/06
5414311	12/1994	Carley	327/552	G11C 27/024
5563819	12/1995	Nelson	708/819	H03H 15/02
5796243	12/1997	Kimura	N/A	N/A
5931899	12/1998	Kertis	708/835	G06G 7/163
6032171	12/1999	Kiriaki	708/319	H03H 15/00
6233598	12/2000	Kertis	N/A	G11B 5/52
6243729	12/2000	Staszewski	N/A	N/A
6791399	12/2003	Jaussi	327/552	H03H 15/00
6859814	12/2004	Kiriaki	708/319	H03H 17/06
7081797	12/2005	Bowers	N/A	N/A
7248189	12/2006	Sinha	341/61	H03H 17/0685
7265527	12/2006	Haug	N/A	N/A
11032167	12/2020	Shayovitz	N/A	H04L 43/028
11522525	12/2021	Subramanian	N/A	H03H 11/265
2001/0056450	12/2000	Kiriaki	708/319	H03H 15/00
2005/0286623	12/2004	Jaussi	375/232	H03H 15/00
2007/0092040	12/2006	Higashino	375/376	H04L 7/10
2017/0070210	12/2016	Kultran	N/A	H03H 15/00
2021/0376818	12/2020	Subramanian	N/A	H03H 17/08

Primary Examiner: Wu; Zhen Y

Attorney, Agent or Firm: KATTEN MUCHIN ROSENMAN LLP

Background/Summary

BACKGROUND

(1) Finite impulse response (FIR) filters use a finite set of coefficients that are convolved with the input signal to produce the output responses for the input values. The FIR filter is one type of digital filter used in digital signal processing. FIR filters can be constructed with continuous time, analog or digital and discrete time signals. FIR filters use operations known as convolution. For example, an Nth order discrete time FIR filter uses N coefficient values and performs convolution operations with the coefficient values and the input values to output the filter's responses.

(2) The FIR filters include electrical circuits to perform the convolution operations. Conventionally, the FIR filters may include a continuous current multiplier that employs multiple current-mode circuits. However, the conventional current-mode circuits necessitate the use of large transistors to mitigate mismatch. For example, in the in-pixel filtering of images on an image sensor, spatial and temporal filtering must be applied at a point closest to the photon transduction in order to benefit from lower power. However, there are strong area constraints for in-pixel circuits, and many desirable conventional current mirror circuits cannot fit in modern pixel pitches.

(3) There are needs to provide compact and efficient electrical circuits for FIR filters that can be used in image sensors with fine pixel pitches, solving the issues of the conventional FIR filters.

SUMMARY

(4) The disclosed invention provides a dynamic current-mode finite impulse response (FIR) filter that combines dynamic current mirrors (DCMs) and the dynamic current multiplier to perform basic filtering operation in a discrete time and continuous amplitude modality. The novel approach to the filtering is achieved by combining a novel dynamic current multiplier with DCMs. The dynamic current multiplier and DCMs of the FIR filter of the disclosed invention allow the design of circuits that are more compact than those of traditional continuous multipliers and mirrors.

(5) These advantages and others are achieved, for example, by a dynamic current-mode finite impulse response (FIR) filter that includes a coefficient signal generator, an input signal generator, a dynamic current multiplier, and an accumulator. The coefficient signal generator is configured to generate a coefficient signal that includes a plurality of continuous or discrete amplitude coefficient values. The input signal generator is configured to generate an input signal that includes a plurality of continuous or discrete amplitude input values. The input signal generator includes a plurality of dynamic current mirrors (DCMs) to output the continuous or discrete amplitude input values. The dynamic current multiplier is configured to receive the input signal and the coefficient signal and to generate intermediate product terms that are multiplications of the coefficient values and reflected and shifted input values. The accumulator is configured to receive the intermediate product terms and to sequentially integrate the intermediate product terms over the coefficient values to produce output responses for the input values. The dynamic current multiplier includes a first dynamically configured transistor (DCT) and a second DCT. The first DCT includes an input node to receive the first input signal during a first phase of operation and a second input signal during a second phase of operation. The second DCT includes an input node to receive a third input signal during a first phase of operation and to output the intermediate product terms during a second phase of operation. A source node of the first DCT is coupled to a source node of the second DCT.

(6) These advantages and others are also achieved, for example, by a method to produce desired output responses by using a dynamic current-mode finite impulse response (FIR) filter. The method includes steps of receiving an input signal at an input node of a first dynamically configured transistor (DCT), receiving a coefficient signal at a coefficient input node, normalizing intermediate product terms that are multiplications of the coefficient values and reflected and shifted input values, outputting the normalized intermediate product terms at an output node of a second DCT, and sequentially integrating the normalized intermediate product terms over the coefficient values to produce output responses for the input values. The input signal includes a plurality of continuous or discrete amplitude input values. The input values are generated by an

input signal generator including a plurality of dynamic current mirrors (DCMs) to output the input values. The coefficient signal includes a plurality of continuous or discrete amplitude coefficient values. A source node of the first DCT is coupled to a source node of the second DCT.

Description

BRIEF DESCRIPTION OF THE DRAWINGS

(1) The preferred embodiments described herein and illustrated by the drawings hereinafter are to illustrate and not to limit the invention, where like designations denote like elements.

(2) FIG. **1** is a diagram of finite impulse response (FIR) filter.

(3) FIG. **2** is an exemplary circuit diagram of typical translinear current multiplier.

(4) FIG. **3** is a circuit diagram of dynamic current multiplier of the disclosed invention that is configured to be used for the FIR filter shown in FIG. **1**.

(5) FIG. **4** shows an exemplary diagram of clock control signals that may be applied to the switches shown in FIG. **3**.

(6) FIG. **5** shows a circuit diagram of the dynamic current-mode FIR filter of the disclosed invention, which employs dynamic current multiplier shown in FIG. **3**.

(7) FIG. **6** is a flowchart that shows a method for producing impulse responses by using the dynamic current-mode FIR filter of the disclosed invention.

DETAILED DESCRIPTION

(8) The following detailed description is merely exemplary in nature and is not intended to limit the described embodiments or the application and uses of the described embodiments. All of the implementations described below are exemplary implementations provided to enable persons skilled in the art to make or use the embodiments of the disclosure and are not intended to limit the scope of the disclosure, which is defined by the claims. It is also to be understood that the drawings included herewith only provide diagrammatic representations of the presently preferred structures of the present invention and that structures falling within the scope of the present invention may include structures different than those shown in the drawings.

(9) With reference to FIG. **1**, shown is a diagram of finite impulse response (FIR) filter **100** of the disclosed invention. The FIR filter **100** uses a finite set of coefficients $c[i]$ **111** which are convolved with the input signal $x[n]$ **112** to produce the output $y[n]$ **114**. For an Nth order discrete time FIR filter, there are N coefficient signals $c[i](i=0 \ldots N-1)$. The basic computation needed for the FIR filter is a summation $y[n]=\Sigma_{i=0}^{N-1} c[i] \times x[n-i]$, where $c[i](i=0 \ldots N-1)$ are coefficient signals and $x[n](n=0, 1, \ldots)$ are input signals. The control unit (not shown) of the FIR filter **100** cycles over the N values of the variable i to compute a value for each output sample $y[n]$.

(10) Referring to FIG. **1**, the FIR filter **100** includes current multiplier **101**, accumulator **102**, input signal generator **104**, and coefficient signal generator **103**. The input signal generator **104** generates an input signal that includes a plurality of continuous or discrete amplitude input values $x[n](n=0, 1, \ldots)$ **112**. The coefficient signal generator **104** generates a coefficient signal that includes a plurality of continuous or discrete amplitude coefficient values $c[i](i=0 \ldots N-1)$ **111**. The multiplier **101** receives N coefficient signals $c[i]$ **111** from coefficient signal generator **103** and receives a subset of N input signals $x[n]$ to $x[n-N+1]$ 112 from an input signal generator **104**. The current multiplier **101** generates intermediate product terms **113** that are multiplications $(c[i] \times x[n-i])$ of the coefficient values $c[i]$ and reflected and shifted input values $x[n-i]$. The accumulator **102** receives the intermediate product terms **113** from the multiplier **101** and generates the output response $y[n]$ **114** for the input value $x[n]$, where $y[n]=\Sigma_{i=0}^{N-1} c[i] \times x[n-i]$. The accumulator **102** sequentially integrates the intermediate product terms over the N coefficient values $c[i](i=0 \ldots N-1)$ **111** and the N input signals $x[n]$ to $x[n-N+1]$ to produce the output responses $y[n]$ **114** for each input value $x[n]$. This operation is known as a convolution operation.

Although in this example the input signals x[n] to x[n−N+1] are temporal samples of signal x, the FIR is not limited to temporal filtering. In some cases the input signal can be a spatial distribution of inputs x[i,j], or even a mix of spatial and temporal inputs x[n,i,j]. The same operations can still be performed, the only limitation being that the set of coefficients is finite.

(11) The disclosed invention provides novel electrical circuits for the current-mode FIR filter **100** to improve the filtering operations. For example, the FIR filter **100** of the disclosed invention improves in-pixel filtering of images on image sensors. In the in-pixel filtering applications, spatial and temporal filtering must be applied at a point closest to the photon transduction in order to benefit from low power. However, there are strong area constraints for in-pixel circuits, and many desirable circuit topologies may not fit in modern pixel pitches. The electrical circuits of the disclosed invention for the FIR filter **100** enables the spatial and temporal filtering to be applied at the closest point to the photon transduction of image sensors.

(12) The FIR filter **100** of the disclosed invention utilizes circuits that combines dynamic current mirrors (DCMs) and dynamic current multiplier for the required filtering operations in a discrete time with discrete or continuous amplitude FIR filtering. In an embodiment, the input signal **112** may be discrete time and discrete amplitude input signal x[n] as described herein, and the FIR filter **100** outputs discrete time output response y[n] which may be quantized into a discrete value signal by further processing. In another embodiment, the input signal **112** may be discrete time and continuous amplitude input signal x[n] as described herein, and the FIR filter **100** outputs discrete time and continuous amplitude output response y[n].

(13) With reference to FIG. **2**, shown is a circuit diagram of a conventional translinear current multiplier **200**. The typical translinear current multiplier **200** includes two transistor pairs **210**, **220**. The transistor pair **210** includes transistors Q**1**, Q**2** **211**, **212**, and the transistor pair **220** includes transistors Q**3**, Q**4** **221**, **222**. The transistor pairs **210**, **220** are connected to each other through line **213**. The current I.sub.a **201** flowing into the drain of transistor Q**1** **211** serves as a first input current, and the current I.sub.b **202** flowing out from the source of transistor Q**2** **212** serves as a second input current. The current I.sub.c **203** flowing into the drain of the transistor Q**3** **221** and out from the source of transistor Q**3** **221** serves as a third input current. The third current I.sub.c **203** to the multiplier **200** is supplied twice as a current source and as a current sink. The current Iout **204** flowing into the drain of the transistor Q**4** **222** serves as an output current of this translinear current multiplier **200**, where

(14) $I_{\text{out}} = \frac{I_a I_c}{I_b}$.

(15) The operation of the translinear current multiplier depends on the exponential relationship between the gate voltage of the transistors and their drain current. That is,

(16) $I_D = I_0 e^{\frac{k V_{GS}}{V_t}}$

where k, V.sub.t and I.sub.0 are parameters, V.sub.GS is the gate to source voltage and ID is the drain current. For transistor Q**1**,

(17) $I_a = I_0 e^{\frac{k(V_1 - V_{bias})}{V_t}}$,

and therefore

(18) $V_1 = V_{\text{bias}} + \frac{V_t}{k} \ln(\frac{I_a}{I_0})$.

For transistor Q**2**,

(19) $I_b = I_0 e^{\frac{k(V_1 - V_2)}{V_t}}$,

and therefore

(20) $V_1 - V_2 = \frac{V_t}{k} \ln(\frac{I_b}{I_0})$,

resulting in

(21) $V_2 = V_{\text{bias}} + \frac{V_t}{k} \ln(\frac{I_a}{I_b})$.

Similarly, for transistor Q**3**,

(22) $I_c = I_0 e^{\frac{k(V_3 - V_{bias})}{V_t}}$,

and therefore

(23) $V_3 - V_2 = \frac{V_t}{k}\ln(\frac{I_c}{I_0})$,

resulting in

(24) $0V_3 = V_{\text{bias}} + \frac{V_t}{k}\ln(\frac{I_a I_c}{I_b I_0})$.

For transistor Q**4**,

(25) $I_{\text{out}} = I_0 e^{\frac{k(V_3 - V_{\text{bias}})}{V_t}}$,

and therefore

(26) $V_3 - V_{\text{bias}} = \frac{V_t}{k}\ln(\frac{I_{\text{out}}}{I_0})$,

resulting in

(27) $V_3 = V_{\text{bias}} + \frac{V_t}{k}\ln(\frac{I_{\text{out}}}{I_0})$.

Therefore

(28) $I_{\text{out}} = \frac{I_a I_c}{I_b}$.

(29) The typical current multiplier **200** is generally well suited for applications that are less sensitive to process variations, or have ample space available to allow the use of large, well-matched transistors. However, the typical current multiplier **200** must operate the transistors in the subthreshold region in order to perform the translinear operations, and therefore has issues when it is used for compact applications. In the subthreshold region, the current multiplier **200** will be very sensitive to process non-uniformity. The FIR filter of the disclosed invention is proposed to overcome the issues of FIR filters using the conventional translinear current multiplier, by achieving similar accuracy without the need for large, well-matched transistors.

(30) With reference to FIG. **3**, shown is a circuit diagram of dynamic current multiplier **300** of the disclosed invention that is configured to be used for the dynamic FIR filter **100**. The dynamic current multiplier **300** utilizes dynamically configured transistors (DCTs) instead of transistor pairs, which are similar to dynamic current mirrors (DCMs), to provide a high precision current multiplier. The dynamic current multiplier **300** includes first DCT **310** and second DCT **320**. Each of the first and second DCTs **310**, **320** includes a drain node **314**, **324**, a source node **315**, **325**, a transistor **311**, **321**, an internal switch **312**, **322**, and at least one capacitor **313**, **323**. A drain of the transistor **311**, **321** is connected to the drain node **314**, **324**, and a source of the transistor **311**, **321** is connected to the source node **315**, **325**. A first terminal of the internal switch **312**, **322** is connected to the drain node **314**, **324**, and a second terminal of the internal switch **312**, **322** is connected to a gate of the transistor **311**, **321**. The internal switch **312**, **322** is configured to be turned on and off by an external control signal. A first terminal of the capacitor **313**, **323** is connected to the second terminal of the internal switch **312**, **322** and the gate of the transistor **311**, **321**.

(31) The source nodes **315**, **325** of the first and second DCTs **310**, **320** are electrically coupled to each other through line **343** and switches **334**, **337**. Herein, "coupled" means that the elements are capable of being electrically connected. For example, the source nodes **315**, **325** are electrically connected when both switches **334**, **337** are turned on, while the source nodes **315**, **325** are electrically disconnected when one of the switches **334**, **337** is turned off. Even though the source nodes **315**, **325** may be electrically disconnected at a certain condition, the source nodes **315**, **325** are electrically coupled because the source nodes **315**, **325** can be electrically connected when both switches **334**, **337** are turned on.

(32) The DCT **310**, **320** includes a single transistor and operates like a time-multiplexed transistor pair that samples a voltage representing an input current on the gate of a transistor and outputs a current that is controlled by the same gate voltage. Unlike the conventional transistor pair **210** shown in FIG. **2**, the DCT **310** includes a single transistor **311** to replicate the functions of transistors Q**1**, Q**2** **211**, **212**. The DCT **310** is configured to be switched between a first mode and second mode by a control signal **541** supplied by controller **540** (see FIG. **5**).

(33) During a first phase of operation of DCT **310**, the internal switch **312** of the first DCT **310** is

turned on. At this time, the switches **331**, **333** are turned on (i.e., the switches **331**, **333** are closed) while the switches **332**, **334** are turned off (i.e., the switches **332**, **334** are open), and the DCM **310** receives the input current I.sub.a **301** through the first input node **341**, the switch **331** and the drain node **314** of the DCT **310**. Because the internal switch **312** is turned on, the gate of the transistor Qa **311** is driven to the appropriate voltage of

(34) $V_{\text{bias}} + \frac{V_t}{k}\ln(\frac{I_a}{I_0})$

(which is the same voltage as V.sub.1 in the continuous translinear current multiplier of FIG. **2**) to pass input current I.sub.a **301**. The capacitor **313** retains the voltage (or charges) of the gate of the transistor Qa **311** during the subsequent phase(s). During a second phase of operation of DCT **310**, the internal switch **312** of the first DCT **310** is turned off. At this time, the switches **331**, **333** are turned off and the switches **332** and **334** are turned on. Because the internal switch **312** is turned off, the gate of the transistor Qa **311** is disconnected from the drain node **314** and is driven by the voltage (charges) of the capacitor **313**, which is retained from the first phase of operation of DCT **310**. Consequently, transistor Qa **311** acts as a voltage follower biased by current I.sub.b, such that the voltage at the source node **315** is given by V

(35) $V_{\text{bias}} + \frac{V_t}{k}\ln(\frac{I_a}{I_b})$

(which is the same voltage as V.sub.2 in the continuous translinear current multiplier of FIG. **2**).
(36) The second DCT **320** operates in a similar way as described for the first DCT **310**, except that the source bias is now

(37) $V_{\text{bias}} + \frac{V_t}{k}\ln(\frac{I_a}{I_0})$

instead of V.sub.bias. During the first phase of operation of DCT **320**, which overlaps with the second phase of operation of DCT **310**, the internal switch **322** of the DCT **320** is turned on. At this time, the switches **335**, **337** are turned on while the switches **336**, **338** are turned off, and the DCT **320** receives the third input current I.sub.c **303** through the switch **335** and the drain node **324**. Because the internal switch **322** is turned on, the gate of the transistor Qb **321** is driven to the appropriate voltage of

(38) $V_{\text{bias}} + \frac{V_t}{k}\ln(\frac{I_a I_c}{I_b I_0})$

(which is the same voltage as V.sub.3 in the continuous translinear current multiplier of FIG. **2**) to pass input current Ic **303** with a source voltage of

(39) $V_{\text{bias}} + \frac{V_t}{k}\ln(\frac{I_a}{I_b})$.

The capacitor **323** retains the voltage (or charges) of the gate of the transistor Qb **321** during subsequent phase(s) of operation.
(40) During the second phase of operation of DCT **320**, which may overlap with the first phase of operation of DCT **310**, the internal switch **322** of the DCT **320** is turned off. At this time, the switches **335**, **337** are turned off and the switches **336** and **338** are turned on. Because the internal switch **322** is turned off, the gate of the transistor Qb **321** is disconnected from the drain node **324** and is driven by the voltage (charges) of the capacitor **323**, which is retained from the first phase of operation of DCT **320**. Moreover, during the second phase of operation of DCT **320**, because the switch **338** is turned on, the source of transistor Qb **321** is connected to V.sub.bias. Consequently, during the second phase of operation, this circuit produces multiplication current Iout **304** flowing into the drain of the transistor Qb **321**, which is an output current Iout **304** of the dynamic current multiplier **300**, where Iout=Ia×Ic/Ib.
(41) In summary, the current I.sub.a **301**, which flows into the drain of the transistor Qa **311** during the first phase of the operation of DCT **310** serves as a first input current, and the current Ib **302** flowing out from the source of the transistor Qa **311** during the second phase of the operation of DCT **310** serves as a second input current. The current I.sub.c **303**, which flows into the drain of the transistor Qb **321** and out of the source of the transistor Qb **310** during the first phase of the operation of DCT **320** serves as a third input current. The third input current Ic **303** to the dynamic current multiplier **300** is supplied twice as a current source at node **345** and as a current sink at

node **346**. The current Iout **304** (Iout=Ia×Ic/Ib) flowing into the drain of the transistor Qb **321** serves as an output current of the dynamic current multiplier **300**, which are the intermediate product terms **113** shown in FIG. **1**.

(42) In the disclosed invention, the current multiplier **101** of the FIR filter **100** shown in FIG. **1** employs the dynamic current multiplier **300** shown in FIG. **3**. The input signals x[n] to x[n−N+1] **112** are sequentially supplied as the first input current I.sub.a **301** of the dynamic current multiplier **300**. The coefficient signals c[0] to c[N−1] 111 are sequentially supplied as the second input current Ib **302**, which requires storing the coefficients as their reciprocal (that is, Ib=1/c[i]). The third input current I.sub.c **303** is supplied to the dynamic current multiplier **300** to normalize the output Iout that is the intermediate product terms. Alternatively, the coefficient signals can be supplied as the third input current I.sub.c **303**, and I.sub.b **302** can be used to normalize the output. A person skilled in the art will recognize that other permutations of the three input currents are also viable.

(43) FIG. **3** exemplarily shows n-channel metal-oxide semiconductor (NMOS) transistors for the transistors **311**, **321**. However, the transistors **311**, **321** may be p-channel metal-oxide semiconductor (PMOS) transistors, bipolar junction transistors or any other types of device exhibiting exponential relationship between a current and a voltage. The switches **312**, **322**, and **331**-**338** may be NMOS transistors, PMOS transistors, bipolar junction transistors or many other types of transistors.

(44) With reference to FIG. **4**, shown is an exemplary diagram of clock control signals **400** that may be applied to control the switches shown in FIG. **3**. The first control signal **410** has a phase φ**1**, the second control signal **420** has a phase φ**2**, the third control signal **430** has a phase φ**3**, the fourth control signal **440** has a phase φ**4**. The first control signal **410** may be applied to the switches **331**, **312**, and **333** to control on/off operations of these switches. For example, with the first control signal **410**, the switches **331**, **312**, and **333** may be turned on during the first phase **411** and may be turned off during the second phase **412** and the third phase **413**. The second control signal **420** may be applied to the switches **332** and **334** to control on/off operations of these switches. For example, with the second control signal **420**, the switches **332** and **334** may be turned off during the first phase **411** and the third phase **413**, and may be turned on during the second phase **412**. The third control signal **430** may be applied to the switches **335**, **322** and **337** to control on/off operations of these switches. For example, with the third control signal **430**, the switches **335**, **322** and **337** may be turned off during the first phase **411** and the third phase **413**, and may be turned on during the second phase **412**. The fourth control signal **440** may be applied to the switches **336** and **338** to control on/off operations of these switches. For example, with the fourth control signal **440**, the switches **336** and **338** may be turned off during the first phase **411** and the second phase **412**, and may be turned on during the third phase **413**.

(45) A person skilled in the art will recognize that the operation of the control signals can also be pipelined. That is, the switches controlled by phase φ1 **410** and phase φ4 **440** can be operated simultaneously, so that parts of the multiplication for index i can overlap with those of i+1, which improves the throughput of the FIR computation. A person skilled in the art will also recognize that inserting idle states into the timing of the control signal may be desirable or necessary to, for example, ensure that there is no overlap between mutually exclusive switches.

(46) With reference to FIG. **5**, shown is a diagram of the dynamic current-mode FIR filter **500** of the disclosed invention, which employs dynamic current multiplier **300** shown in FIG. **3**. The FIR filter **500** includes coefficient signal generator **510**, input signal memory **520**, dynamic current multiplier **300**, and accumulator **530**. The current-mode FIR filter **500** may further include controller **540** to control the operations of switches and elements included in the FIR filter **500** with control signals **541**, **542**, **543**. The controller **540** may be a typical controller that generates clock signals that are configured to operate transistors or the other types of switches.

(47) The coefficient signals c[i] **111** can be generated by either dynamic current mirrors (DCMs) or

continuous current sources. FIG. **5** exemplarily shows the coefficient signal generator **510** including DCMs **511**. However, the DCMs **511** may be replaced with continuous-time current sources in the circuit of the coefficient signal generator **510**. For the Nth order discrete time FIR filter, there may be N DCMs to sequentially generate coefficient signals c[i](i=0, . . . , N−1) **111**. In an embodiment, if the input signals contain time samples of the input signal x[n] **112**, then these samples x[n-i] are stored in DCMs. The input signal memory **520** includes a finite number of DCMs **521** to generate input signals x[i](i=n, . . . , n−N+1) **112**. The input signal memory **520** implements either a circular buffer or a shift registers circuit for the input temporal samples so that new samples can be added, and the oldest samples discarded. FIG. **5** exemplarily shows the coefficient signal generator **510** includes DCMs **511** having an NMOS transistor and the input signal memory **520** includes DCMs **521** having a PMOS transistor. However, the transistors for the DCMs of the coefficient signal generator **510** and the input signal memory **520** are not limited to these transistors.

(48) The third input signal I.sub.c **303** is supplied to the third input node **345** by the third input signal source **550**. The third input signals **303** may be generated by either DCMs or continuous-time current sources. The input signal x[n-i] **112** is supplied to the dynamic current multiplier **300** via the first input node **341**, and the coefficient signal c[i] **111** is supplied to the dynamic current multiplier **300** via the second input node **342**. The dynamic current multiplier **300** produces the intermediate product terms c[i]×x[n-i] and use the third input signal **303** to normalize the intermediate product terms. The normalized intermediate product terms are output at the output node **344**.

(49) The accumulator **530** receives the normalized intermediate product terms c[i]×x[n-i] and performs integration or summation operations: y[n]=Σ.sub.i=0.sup.N−1c[i]× x[n−i]. The accumulator **530** includes two DCMs **531**, **532**. During a first phase of operation of the accumulator **530**, the normalized intermediate product term c[i]×x[n-i]from the dynamic current multiplier **300** is added to the running sum supplied by DCM **532**, and stored in DCM **531**. The running sum is Σ.sub.j=0.sup.i−1c[j]×x[n−j]. During a second phase of operation of the accumulator **530**, the current from DCM **531** is transferred in DCM **532**, such that DCM **532** now stores Σ.sub.j=0.sup.i−1c[j]×x[n−j]. The process is then repeated for the next step (i+1). Note that for the first step (i=0), the content of DCM **532** is not added to the first intermediate product term c[0]×x[n]. At the end of the N cycles, the output y[n] of the FIR filter **500** is available from either DCM. The switch **553** controls timing to send the intermediate product terms to accumulator **530**, and the switch **534** controls timing to send the previously sequentially integrated intermediate product terms from DCM **532** to DCM **531** and to send newly integrated intermediate product terms from DCM **531** to DCM **532**. In an embodiment, the DCM **531** may be PMOS DCM including a PMOS transistor, and the DCM **532** may be NMOS DCM including an NMOS transistor. However, the transistors of the DCMs **531**, **532** are not limited to these. The DCMs **531**, **532** may include opposite types of transistors.

(50) With reference to FIG. **6**, shown is a flowchart that shows a method **600** for producing FIR filter responses by using the dynamic current mode FIR filter **500**. Referring to FIG. **6**, in block S**601**, in the dynamic current multiplier **300**, an input signal x[n-i]**301** is received at the first input node **341** of first DCT **310** during a first phase of operation of DCT **310**. This process S**601** is achieved by turning on switches **331**, **312** and **333** and turning off switches **332** and **334**, via a controller **540**, during the first phase of operation of DCT **310**.

(51) In block S**602**, in the dynamic current multiplier **300**, a coefficient signal c[i]**302** is received at the second input node **342** of the first DCT **310** during a second phase of operation of DCT **310**. This process S**602** is achieved by turning off switches **331**, **312** and **333** and turning on switches **332** and **334**, via controller **540**, during the second phase of operation of DCT **310**.

(52) In block S**603**, an intermediate product term is normalized by the current supplied at the third input node **345** from signal source **550**. This process S**603** is achieved by turning on switches **335**,

322 and **337** and turning off switches **336** and **338**, via controller **540** during the first phase of operation of DCT **320**.

(53) In block S**604**, a normalized intermediate product term c[i]×c[n-i] is produced at output node **344**. This process S**604** is achieved by turning on switches **336** and **338** and turning off switches **335**, **322** and **337**, via controller **540** during the second phase of operation of DCT **320**.

(54) In block S**605**, the normalized intermediate product terms are sequentially integrated by accumulator **530**, to the FIR output y[n] for the input value x[n]. This process S**605** is achieved by adding the normalized intermediate product term c[i]×c[n-i] to the previously integrated normalized product terms (for the smaller indices of i) supplied by DCM **532**, and storing the sum in DCM **531**. The content of DCM **531** is then copied back to DCM **532**. At the end of the integration period, the output signal y[n]Σ.sub.i=0.sup.N−1c[j]×x[n−i] is produced by accumulator **530**.

(55) Since many modifications, variations, and changes in detail can be made to the described preferred embodiments of the invention, it is intended that all matters in the foregoing description and shown in the accompanying drawings be interpreted as illustrative and not in a limiting sense. Consequently, the scope of the invention should be determined by the appended claims and their legal equivalents.

Claims

1. A dynamic current-mode finite impulse response (FIR) filter, comprising: a coefficient signal generator configured to generate a coefficient signal that includes a plurality of continuous or discrete amplitude coefficient values; an input signal generator configured to generate an input signal that includes a plurality of continuous or discrete amplitude input values, wherein the input signal generator comprises a plurality of dynamic current mirrors (DCMs) to output the continuous or discrete amplitude input values; a dynamic current multiplier configured to receive the input signal and the coefficient signal and to generate intermediate product terms that are multiplications of the coefficient values and reflected and shifted input values, wherein the dynamic current multiplier comprises: a first dynamically configured transistor (DCT) comprising an input node to receive the first input signal during a first phase of operation and a second signal during a second phase of operation; and a second DCT comprising an input node to receive a third input signal during a first phase of operation, and to output the intermediate product terms during a second phase of operation, wherein a source node of the first DCT is coupled to a source node of the second DCT; and an accumulator configured to receive the intermediate product terms and to sequentially integrate the intermediate product terms over the coefficient values to produce output responses for the input values.

2. The dynamic current-mode FIR filter of claim 1 wherein the dynamic current multiplier comprises a signal input node coupled to an input signal memory to sequentially receive the input signal values.

3. The dynamic current-mode FIR filter of claim 1 wherein the dynamic current multiplier comprises a coefficient input node coupled to the coefficient signal generator to sequentially receive the coefficient values.

4. The dynamic current-mode FIR filter of claim 1 wherein each of the first and second DCTs of the dynamic current multiplier comprises: the input node, the source node, and an output node; a transistor comprising a drain connected to the input node, and a source connected to the source node; an internal switch comprising a first terminal connected to the input node, and a second terminal connected to a gate of the transistor, wherein the internal switch is configured to be turned on during a first phase of operation and turned off during a second phase of operation; and at least one capacitor comprising a first terminal connected to the second terminal of the internal switch and the gate of the transistor.

5. The dynamic current-mode FIR filter of claim 4 wherein the transistors of the first and second DCTs are both n-channel metal-oxide semiconductor (NMOS) transistors or both p-channel metal-oxide semiconductor (PMOS) transistors.

6. The dynamic current-mode FIR filter of claim 1 wherein the accumulator comprises: a first DCM configured to store previously sequentially integrated intermediate product terms; and a second DCM configured to integrate currently received intermediate product term into the previously sequentially integrated intermediate product terms.

7. The dynamic current-mode FIR filter of claim 6 wherein the one DCM of the accumulator comprises a PMOS transistor, and the other DCM of the accumulator comprises a NMOS transistor.

8. The dynamic current-mode FIR filter of claim 1 wherein the coefficient signal generator comprises DCMs to generate the continuous or discrete amplitude coefficient values.

9. A method to produce desired output responses by using a dynamic current-mode finite impulse response (FR) filter, comprising: receiving an input signal at an input node of a first dynamically configured transistor (DCT) during a first phase of operation, wherein the input signal includes a plurality of continuous or discrete amplitude input values, wherein the input values are generated by an input signal generator comprising a plurality of dynamic current mirrors (DCMs) to output the input values; receiving a coefficient signal at a coefficient input node, wherein the coefficient signal includes a plurality of continuous or discrete amplitude coefficient values; normalizing intermediate product terms that are multiplications of the coefficient values and reflected and shifted input values; outputting the normalized intermediate product terms at an output node of a second DCT during a second phase of operation, wherein a source node of the first DCT is coupled to a source node of the second DCT; and sequentially integrating the normalized intermediate product terms over the coefficient values to produce output responses for the input values.

10. The method of claim 9 further comprising receiving a third input signal at the input node of the second DCT during the first phase of operation, wherein the third input signal is used to normalize the intermediate product terms.

11. The method of claim 9 wherein the sequentially integrating the normalized intermediate product terms comprises: storing previously sequentially integrated intermediate product terms at a first DCM of an accumulator; and integrating currently received intermediate product term into the previously sequentially integrated intermediate product terms at a second DCM of the accumulator.

12. The method of claim 9 wherein each of the first and second DCTs of the dynamic current multiplier comprises: the input node, the source node and an output node; a transistor comprising a drain connected to the input node, and a source connected to the source node; an internal switch comprising a first terminal connected to the input node, and a second terminal connected to a gate of the transistor, wherein the internal switch is configured to be turned on during a first phase of operation and turned off during a second phase of operation; and at least one capacitor comprising a first terminal connected to the second terminal of the internal switch and the gate of the transistor.

13. The method of claim 12, wherein the transistors of the first and second DCTs are both n-channel metal-oxide semiconductor (NMOS) transistors or both p-channel metal-oxide semiconductor (PMOS) transistors.